

**Notice of References Cited**

Application/Control No.

10/530,286

Applicant(s)/Patent Under  
Reexamination  
FUNAWATARI ET AL.

Examiner

William J. Klimowicz

Art Unit

2627

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,590,858	07-2003	Inoue, Naoki	720/742
*	B	US-6,898,795	05-2005	Inoue, Naoki	720/644
*	C	US-6,944,875	09-2005	Kawaguchi et al.	720/741
*	D	US-2001/0046104	11-2001	Inoue et al.	360/133
*	E	US-2004/0027721	02-2004	Imai, Fumihito	360/133
*	F	US-2004/0047191	03-2004	Inoue, Naoki	365/200
*	G	US-2004/0210921	10-2004	Shibagaki et al.	720/741
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.